

DIGITRON SEMICONDUCTORS

2N1881-2N1885

SILICON CONTROLLED RECTIFIER

1 AMP

Available Non-RoHS (standard) or RoHS compliant (add PBF suffix).

Available as "HR" (high reliability) screened per MIL-PRF-19500, JANTX level. Add "HR" suffix to base part number.

MAXIMUM RATINGS

Rating	Symbol	2N1881	2N1882	2N1883	2N1884	2N1885	Unit
Repetitive peak off state voltage	V_{DRM}	30	60	100	150	200	Volts
Repetitive peak reverse voltage	V_{RRM}	30	60	100	150	200	Volts
DC on-state current 100°C ambient 100°C case	I_T			250 1.0			mA Amps
Repetitive peak on-state current	I_{TRM}			Up to 30			Amps
Peak one cycle surge (non-repetitive) on-state current	I_{TSM}			15			Amps
Peak gate current	I_{GM}			250			mA
Average gate current	$I_{G(AV)}$			25			mA
Reverse gate voltage	V_{GR}			3			Volts
Thermal resistance, junction to case	R_{sJC}			20			°C/W
Operating and storage temperature range	T_J, T_{stg}			-65 to 150			°C

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristics	Symbol	Min	Typ	Max	Unit	Test Condition
Subgroup 2 (25°C test)						
Off-state current	I_{DRM}	-	0.5	10	μA	$V_{DRM} = \text{rating}, R_{GK} = 1\text{K}\Omega$
Reverse current	I_{RRM}	-	0.5	10	μA	$V_{RRM} = \text{rating}, R_{GK} = 1\text{K}\Omega$
Reverse gate current	I_{GR}	-	0.5	10	μA	$V_{GR} = 2\text{V}$
Gate trigger current	I_{GT}	-	0.2	2	mA	$V_D = 5\text{V}, R_{GS} = 10\text{K}\Omega$
Gate trigger voltage	V_{GT}	0.40	1.0	2	V	$V_D = 5\text{V}, R_{GS} = 100\Omega$
On-state voltage	V_T	-	1.5	2	V	$I_T = 1\text{A}(\text{pulse test})$
Holding current	I_H	-	2.0	-	mA	$I_G = -150\mu\text{A}, V_D = 5\text{V}$
Anode trigger current	I_{AT}	-	0.5	-	mA	$R_{GS} = 10\text{K}\Omega, V_D = 5\text{V}$
Subgroup 3 (125°C test)						
Turn-on time	t_{on}	-	0.2	-	μs	$I_G = 20\text{mA}, I_T = 0.5\text{A}, V_D = 30\text{V}$
Gate trigger – on pulse width	$t_{pg(on)}$	-	1.0	-	μs	$I_G = 20\text{mA}, I_T = 0.5\text{A}, V_D = 30\text{V}$
Turn-off time	t_{off}	-	1.0	-	μs	$I_T = 1\text{A}, I_R = 1\text{A}, R_{GK} = 1\text{K}\Omega$
Circuit commutated turn-off time	t_q	-	10	-	μs	$I_T = 1\text{A}, I_R = 1\text{A}, R_{GK} = 1\text{K}\Omega$
Subgroup 3 (125°C test)						
High temperature off-state current	I_{DRM}	-	15	200	μA	$R_{GK} = 1\text{K}\Omega, V_{DRM} = \text{rating}$
High temperature reverse current	I_{RRM}	-	15	200	μA	$R_{GK} = 1\text{K}\Omega, V_{RRM} = \text{rating}$

Voltage ratings apply over the operating temperature range, provided the gate is connected to the cathode through an appropriate resistor, or adequate gate bias is used.

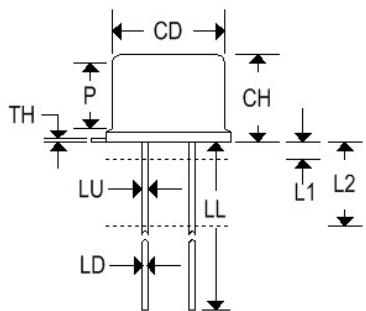
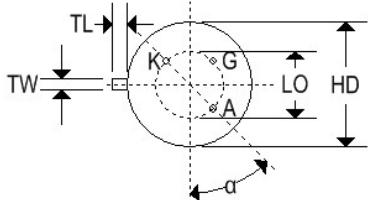
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1 AMP

MECHANICAL CHARACTERISTICS

Case	TO-5
Marking	Body painted, alpha-numeric
Pin out	See below



Dim	TO-5			
	Inches		Millimeters	
	Min	Max	Min	Max
HD	0.335	0.370	8.510	9.400
CD	0.305	0.335	7.750	8.510
CH	0.240	0.260	6.100	6.600
LL	1.500	-	38.100	-
LD	0.016	0.021	0.410	0.530
LU	0.016	0.019	0.410	0.480
P	0.100	-	2.540	-
TL	0.029	0.045	0.740	1.140
TW	0.028	0.034	0.710	0.860
TH	0.009	0.125	0.230	3.180
LO	0.141 NOM		3.590 NOM	
α	45°TP		45°TP	